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Sheet 1 of 2

Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Atty. Docket No. 27392/29382	Serial No. <b>10/575741</b>
<b>INFORMATION DISCLOSURE STATEMENT</b>		Applicant <b>Kraemer</b>	
		Filing Date April 22, 2005	Group <b>2878</b>

U.S. PATENT DOCUMENTS							
*Examiner Initials	Document Number	Issue Date	Name	Class	Subclass	Filing Date if Appropriate	
/SCS/	3,662,289	05/09/72	Dienst	332	3		
/SCS/	4,832,433	05/23/89	de La Chapelle et al.	350	96.15		
/SCS/	4,859,965	08/22/89	Paolella et al.	330	285		
/SCS/	5,073,717	12/17/91	Sturzebecher et al.	250	551		
/SCS/	5,073,718	12/17/91	Paolella	250	551		
/SCS/	5,086,281	02/04/92	Paolella	330	279		
/SCS/	5,162,657	11/10/92	Sturzebecher et al.	250	551		
/SCS/	5,313,138	05/17/94	Desmur	315	3		
/SCS/	5,347,235	09/13/94	Higgins et al.	331	66		
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/SCS/	5,808,322	09/15/98	Nicholson et al.	257	80		
/SCS/	2004/0036462A1	02/26/04	Evers et al.	323	369		
/SCS/	6,876,271 B2	04/05/05	Evers et al.	333	81 A	01/24/03 06/24/03	

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*Examiner Initials	Document Number	Publication Date	Country	Class	Subclass	Translation	
						Yes	No
/SCS/	869 611 A1	10/07/98	EP				
/SCS/	698 01 177 T2	03/21/02	Germany			Abstract only	
/SCS/	102 28 810 A1	01/29/04	Germany			Abstract only	
/SCS/	37 89 229 T2	10/06/94	Germany			Abstract only	
/SCS/	63055978	03/10/88	Japan			Abstract only	
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Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Atty. Docket No. 27392/29382	Serial No. 1015757
<b>INFORMATION DISCLOSURE STATEMENT</b>		Applicant Kraemer	
		Filing Date April 22, 2005	Group 2878

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)		
/SCS/		"Analysis of Gate Lag in GaAs Metal-Semiconductor Field-Effect Transistor Using Light Illumination", Sasaki et al., J. Appl. Phys. Vol. 34, 1995, pp. 6346-6351
/SCS/		International Search Report in PCT/EP2005/004330 dated November 10, 2005

Examiner	/Seung C Sohn/	Date Considered	11/26/2007
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.			